



PIXIS-XO:2048B

2048 x 2048 imaging array | 13.5x 13.5 µm pixels |Soft X-ray detection

The PIXIS-XO series of fully integrated imaging cameras utilizes back-illuminated (BI) CCDs without AR coating, for direct detection of the widest range of X-rays between $\sim 10 \text{ eV}$ and 30 keV (AR coated devices are not useful for X-ray energies < 500eV). With a 2048 x 2048 imaging array, 13.5 μ m pixels, 100% fill factor, low noise electronics and -50° C to -70° C thermoelectric cooling with either air or water, this system is ideal for worry-free operation in research and OEM environments. The rotatable conflat flange with high-vacuum-seal design, software selectable gains and readout speeds make these cameras well suited for ultra-high vacuum applications.

FEATURES	BENEFITS	
Back-illuminated CCD, with no AR coating	Provides very low X-ray flux imaging, high sensitivity and high spatial resolution	
2 Mhz / 16-bit readout 100 kHz / 16-bit readout	High speed readout for rapid image acquisition; Slow speed readout for high sensitivity with wide dynamic range, high signal-to-noise ratio (SNR) and excellent energy resolution	
Software selectable gains for each digitization speed	Allows optimization of system performance for lowest noise to highest SNR	
2048 x 2048 image area, 13.5 x 13.5 μm pixels	Wide field of view, highest resolution with 13.5 μm pixel	
Ultra low noise electronics	Best possible system performance	
Flexible user-selectable binning & readout	Total flexibility to optimize experiments and SNR	
Kinetics	Custom readout mode offers microsecond resolution	
Deep thermoelectric air cooling	Maintenance-free operation - No need for a liquid circulator or additional power supply	
Deep thermoelectric water cooling	Vibration-free operation	
Conflat vacuum interface	Industry-standard, high-vacuum compatibility	
TTL input and output	External Trigger input with programmable polarity; TTL output with exposure or readout monitor	
USB 2.0 interface	Seamless, plug-and-play connection to PC notebooks & desktops; Easy OEM integration	
Optional: LightField ® (for Windows 10/8/7, 64-bit) Or WinView/Spec (for Windows 8/7/XP, 32-bit)	Flexible software packages for data acquisition, display and analysis with built in math engine; LightField offers intuitive, cutting edge user interface and more.	
PICAM (64-bit) / PVCAM (32-bit) software development kits (SDKs)	Compatible with Windows 10/8/7 (64-bit), and Linux (contact factory for an update) Universal programming interfaces for easy custom programming.	
LabView® Scientific Imaging ToolKit (SITK™)	Predefined VIs for easy integration of camera controls into large experiment	

Applications:

X-ray Imaging, X-ray Microscopy, EUV Lithography and X-ray Plasma Diagnostics

PIXIS-XO:2048B Rev. P1.1



SPECIFICATIONS

	PIXIS-XO: 2048B	PIXIS-XO: 2048BUV/BR*	
CCD Image Sensor	e2v CCD42-40; scientific grade 1; MPP; BI-basic process (B); no AR coating; for sensitivity between ~10 eV to 30 keV	e2v CCD42-40; scientific grade 1; NIMO; BI-enhanced process (BUV), BI-deep depletion (BR); no AR coating; for sensitivity between ~10 eV to 30 keV	
Dark current @ -60° C (with ambient air @ +20° C)	0.002 e-/p/sec (typical) 0.006 e-/p/sec (max)	0.2 e-/p/sec (typical) 2 e-/p/sec (max)	
CCD format	2048 x 2048 imaging pixels; 13.5 x 13.5 µm pixels; 100% fill factor; 27.6 x 27.6 mm (optically centered)		
Deepest cooling temperature, TE air cooling** (with ambient air @ +20° C)	-70° C (typical); -60° C (guaranteed) with CoolCUBE II liquid circulator -60° C (typical); -50° C (guaranteed) with air		
Thermostating precision	±0.05° C		
Cooling method	Thermoelectric air or liquid cooling (CoolCUBE II required)		
Full well	Single pixel:100 ke- (typical), 80 ke- (minimum)High Sensitivity node:250 ke- (typical), 220 ke- (minimum)High Capacity node:1000 ke- (typical), 800 ke- (minimum)		
ADC speed/bits	100 kHz/16-bit and 2 MHz/16-bit		
System read noise @100 kHz @2 MHz	3.5 e- rms (typical), 5 e- rms (max) 12 e- rms (typical), 16 e- rms (max)		
Vertical shift speed	32.2 μsec/row (programmable)		
Non-linearity	<2% @ 100 kHz		
Software selectable gains	1, 2, 4 e-/ADU (low noise input); 3.5, 7, 14 e-/ADU (high capacity output)		
Operating systems supported	Windows XP/Vista/7; Linux		
Data interface	USB2.0 (5m interface cable provided); Optional Fiberoptic interface is available for remote operation		
I/O signals	Two MCX connectors for programmable frame readout, shutter, trigger in		
Operating environment	$+5^{\circ}$ C to $+30^{\circ}$ C non-condensing		
Bakeout temperature	70° C (maximum)		
Vacuum Compatibility	10 ⁻⁸ Torr		
Certification	CE		
Dimensions / Weight	15.1 cm (5.95") x 15.24 cm (6.00") x 15.24 cm (6.00") (L x W x H) / 3.86 kg (8.5 lbs)†		

NOTES: All specifications subject to change

* Contact your local sales representative for information on the availability of the BUV / BR model.

** The minimum temperature attainable is dependent on the vacuum condition - temperature can be lowered w/lower vacuum.

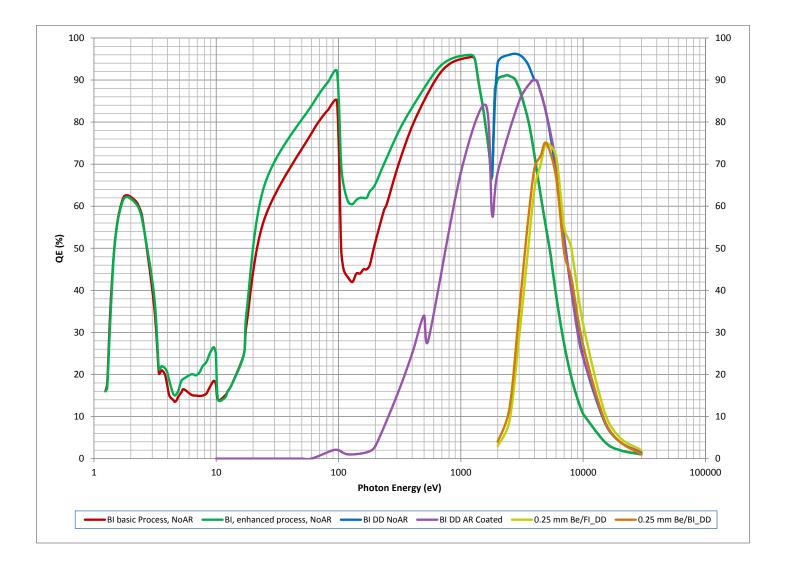
† The weight of the camera is with 6.00" Conflat flange and air cooling.

Readout Rates	Binning	@ 2 MHz	@100 kHz
	1 x 1	2.265 sec	36.45 sec
	2 x 2	0.956 sec	9.521 sec
	4 x 4	0.458 sec	2.595 sec
	8 x 8	0.249 sec	0.738 sec
	16 x 16	0.154 sec	0.288 sec

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QUANTUM EFFICIENCY CURVES

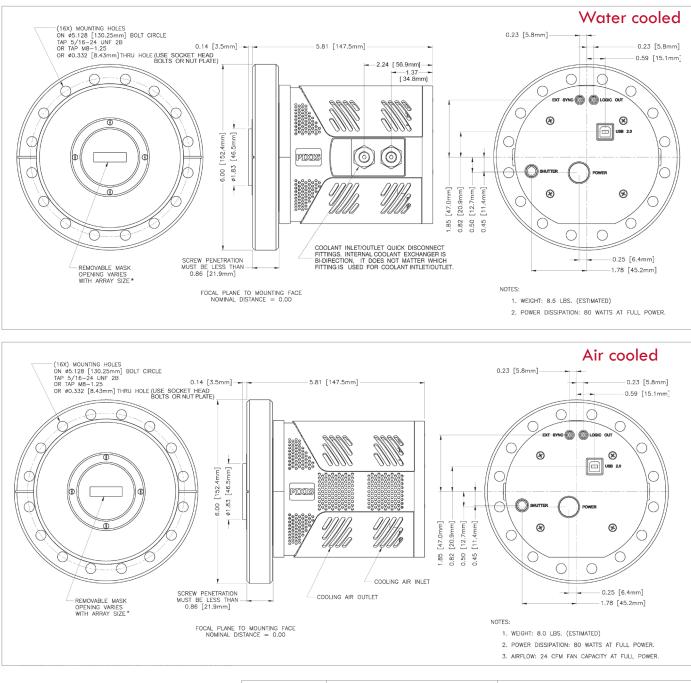


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OUTLINE DRAWING

6" Conflat



CCD Array	CCD Image Area inches (mm)	Mask Opening ± .001 inches (± .0254 mm)
2048 x 2048	1.087 x 1.087 (27.6 x 27.6)	1.083 x 1.083 (27.508 x 27.508)

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